Search Notes

	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/700,630	ISHIKAWA ET AL.	
ſ	Examiner	Art Unit	
	Sophia S. Chen	2852	

SEARCHED					
Class	Subclass	Date	Examiner		
399	50	5/2/2005	sc		
	53	1	1		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Text Search (see printout)	5/2/2005	SC		